

Notice of References Cited	Application/Control No. 10/784,829	Applicant(s)/Patent Under Reexamination SAKATA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0165116	09-2003	Fallon et al.	370/230.1
*	B	US-2003/0123391	07-2003	Chen et al.	370/230.1
*	C	US-2003/0123390	07-2003	Takase et al.	370/230.1
*	D	US-2003/0099200	05-2003	Kiremidjian et al.	370/230.1
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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